

Notice of References Cited	Application/Control No. 10/699,060	Applicant(s)/Patent Under Reexamination BENJAMIN ET AL.	
	Examiner Christopher Verdier	Art Unit 3745	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,923,616 B2	08-2005	McRae et al.	415/115
	B	US-5,281,097 A	01-1994	Wilson et al.	416/193A
	C	US-6,808,368 B1	10-2004	Tomberg et al.	416/223A
	D	US-6,341,939 B1	01-2002	Lee	416/97R
	E	US-2,915,279 A	12-1959	Chamberlin	416/97R
	F	US-2005/0095129 A1	05-2005	Benjamin et al.	416/097.00R
	G	US-6,416,284 B1	07-2002	Demers et al.	416/97R
	H	US-6,419,447 B1	07-2002	Watanabe et al.	415/115
	I	US-6,273,683 B1	08-2001	Zagar et al.	416/193A
	J	US-2,912,223 A	11-1959	Hull, Jr.	416/500
	K	US-6,086,329 A	07-2000	Tomita et al.	416/193A
	L	US-4,917,574 A	04-1990	Dodd et al.	416/193A
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.